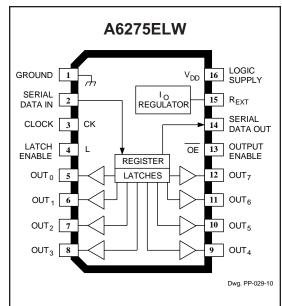
6275

PRODUCT PREVIEW

(Subject to change without notice) December 22, 1998



Note that the A6275EA (DIP) and the A6275ELW (SOIC) are electrically identical and share a common terminal number assignment.

ABSOLUTE MAXIMUM RATINGS

Supply Voltage, V_{DD}
Output Voltage Range,
$V_{\rm O}$ 0.5 V to +17 V
Output Current, I _O 90 mA
Ground Current, $I_{GND} \ldots \ldots 750 \ \textbf{mA}$
Input Voltage Range,
$\rm V_{I}$ -0.4 V to $\rm V_{DD}$ + 0.4 V
Package Power Dissipation,
P _D See Graph
Operating Temperature Range,
T_A
Storage Temperature Range,
T_S 55°C to +150°C
Caution: These CMOS devices have input static

Caution: These CMOS devices have input static protection (Class 2) but are still susceptible to damage if exposed to extremely high static electrical charges.

8-BIT SERIAL-INPUT, CONSTANT– CURRENT LATCHED LED DRIVER

The A6275EA and A6275ELW are specifically designed for LEDdisplay applications. Each BiCMOS device includes an 8-bit CMOS shift register, accompanying data latches, and eight npn constantcurrent sink drivers. Except for package style and allowable package power dissipation, the two devices are identical.

The CMOS shift register and latches allow direct interfacing with microprocessor-based systems. With a 5 V logic supply, typical serial data-input rates are up to 20 MHz. The LED drive current is determined by the user's selection of a single resistor. A CMOS serial data output permits cascade connections in applications requiring additional drive lines. For inter-digit blanking, all output drivers can be disabled with an ENABLE input high. Similar 16-bit devices are available as the A6276EA and A6276ELW.

Two package styles are provided for through-hole DIP (suffix A) or surface-mount SOIC (suffix LW). Under normal applications, copper lead frames and low logic-power dissipation allow these devices to sink maximum rated current through all outputs continuously over the operating temperature range (90 mA, 0.9 V drop, +85°C).

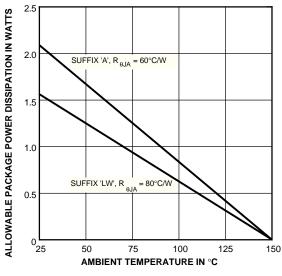
FEATURES

- To 90 mA Constant-Current Outputs
- Under-Voltage Lockout
- Low-Power CMOS Logic and Latches
- High Data Input Rate
- Pin-Compatible with TB62705CP

This document contains information on a product under development. Allegro MicroSystems, Inc. reserves the right to change or discontinue this product without notice.

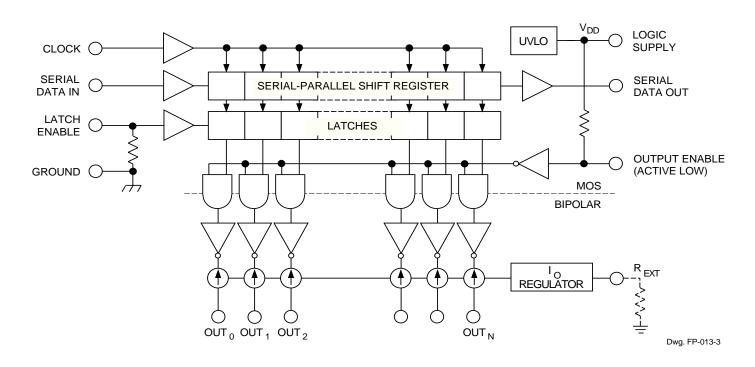
Always order by complete part number, e.g., A6275EA.





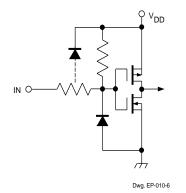
Dwg. GP-018B

FUNCTIONAL BLOCK DIAGRAM

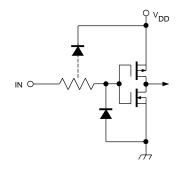




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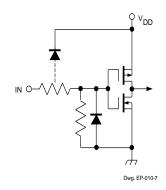


OUTPUT ENABLE (active low)

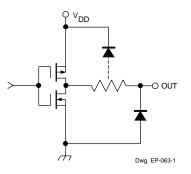


Dwg. EP-010-5

CLOCK and SERIAL DATA IN



LATCH ENABLE



SERIAL DATA OUT

TRUTH TABLE

Serial		Shift Register Contents			Serial Latch	Latch Contents					Output	Output Contents									
Data Input	Clock Input	I ₁	I ₂	I ₃		I _{N-1}	I _N	Data Enable Output Input		I ₁	I ₂	I ₃		I _{N-1}	I _N	Enable Input	I ₁	l ₂	3	I _{N-1}	I _N
Н	Ъ	н	R ₁	R ₂		R _{N-2}	R _{N-1}	R _{N-1}													
L	Г	L	R_1	R_2		R _{N-2}	R _{N-1}	R _{N-1}													
х	l	R ₁	R_2	R_3		R _{N-1}	R _N	R _N													
		х	Х	Х		Х	Х	x	L	R ₁	R_2	R_3		R _{N-1}	R _N						
		Р ₁	P_2	Ρ3		P _{N-1}	P _N	P _N	Н	P ₁	P ₂	P ₃		P _{N-1}	Ρ _N	L	P ₁	P ₂ F	o ₃	P _{N-1}	P _N
										Х	Х	Х		Х	Х	Н	Н	Ηŀ	Η	Н	Н
L = Lo	L = Low Logic (Voltage) Level H = High Logic (Voltage) Level X = Irrelevant P = Present State R = Previous State																				

ELECTRICAL CHARACTERISTICS at T_A = +25°C, V_{DD} = 5 V (unless otherwise noted).

				Lim	its	
Characteristic	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Supply Voltage Range	V _{DD}	Operating	4.5	5.0	5.5	V
Under-Voltage Lockout	V _{DD(UV)}	V_{DD} = 0 \rightarrow 5 V	3.4	_	4.0	V
Output Current	Ι _ο	V_{CE} = 0.7 V, R_{EXT} = 250 Ω	64.2	75.5	86.8	mA
(any single output)		V_{CE} = 0.7 V, R_{EXT} = 470 Ω	34.1	40.0	45.9	mA
Output Current Matching	ΔI_O	0.4 V \leq V _{CE(A)} = V _{CE(B)} \leq 0.7 V:				
(difference between any		R_{EXT} = 250 Ω	-	±1.5	±6.0	%
two outputs at same V _{CE})		R _{EXT} = 470 Ω	-	±1.5	±6.0	%
Output Leakage Current	I _{CEX}	V _{OH} = 15 V	_	1.0	5.0	μA
Logic Input Voltage	V _{IH}		0.7V _{DD}	_	V_{DD}	V
	V _{IL}		GND	_	$0.3V_{DD}$	V
SERIAL DATA OUT	V _{OL}	I _{OL} = 500 μA	_	_	0.4	V
Voltage	V _{OH}	I _{OH} = -1.0 mA	4.6	_	-	V
Input Resistance	RI	ENABLE Input, Pull Up	150	300	600	kΩ
		LATCH Input, Pull Down	100	200	400	kΩ
Supply Current	I _{DD(OFF)}	R _{EXT} = open, V _{OE} = 5 V	_	0.8	1.4	mA
		R_{EXT} = 470 Ω , V_{OE} = 5 V	3.5	6.0	8.0	mA
		R_{EXT} = 250 Ω , V_{OE} = 5 V	6.5	11	15	mA
	I _{DD(ON)}	R_{EXT} = 470 Ω , V_{OE} = 0 V	5.0	10	14	mA
		R _{EXT} = 250 Ω, V _{OE} = 0 V	8.0	16	24	mA

Typical Data is at $V_{DD} = 5$ V and is for design information only.

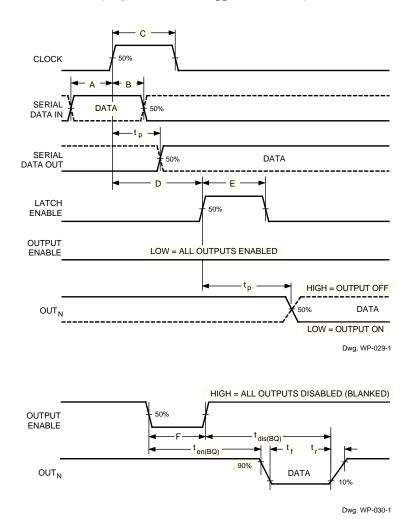


SWITCHING CHARACTERISTICS at $T_A = 25^{\circ}C$, $V_{DD} = V_{IH} = 5 V$, $V_{CE} = 0.4 V$, $V_{IL} = 0 V$, $R_{EXT} = 470 \Omega$, $I_O = 40 \text{ mA}$, $V_L = 3 V$, $R_L = 65 \Omega$, $C_L = 10.5 \text{ pF}$.

				Li	mits	_
Characteristic	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Propagation Delay Time	t _{pLH}	CLOCK-OUT _n	-	1200	1500	ns
		LATCH-OUT _n		1200	1500	ns
		ENABLE-OUT _n	-	1200	1500	ns
		CLOCK-SERIAL DATA OUT	-	30	70	ns
Propagation Delay Time	t _{pHL}	CLOCK-OUT _n	-	700	1000	ns
		LATCH-OUT _n	-	700	1000	ns
		ENABLE-OUT _n	-	700	1000	ns
		CLOCK-SERIAL DATA OUT	-	30	70	ns
Output Rise Time	t _r	10% to 90% voltage	300	600	1000	ns
Output Fall Time	t _f	90% to 10% voltage	150	300	600	ns

RECOMMENDED OPERATING CONDITIONS

Characteristic	Symbol	Conditions	Min.	Тур.	Max.	Unit
Supply Voltage	V _{DD}		4.5	5.0	5.5	V
Output Voltage	Vo		-	1.0	4.0	V
Output Current	Ι _Ο	Continuous, any one output	-	-	90	mA
	I _{OH}	SERIAL DATA OUT	-	-	-1.0	mA
	I _{OL}	SERIAL DATA OUT	-	-	1.0	mA
Logic Input Voltage	V _{IH}		0.7V _{DD}	-	V _{DD} + 0.3	V
	V _{IL}		-0.3	-	0.3V _{DD}	V
Clock Frequency	f _{CK}	Cascade operation	-	-	10	MHz



TIMING REQUIREMENTS and SPECIFICATIONS

(Logic Levels are V_{DD} and Ground)

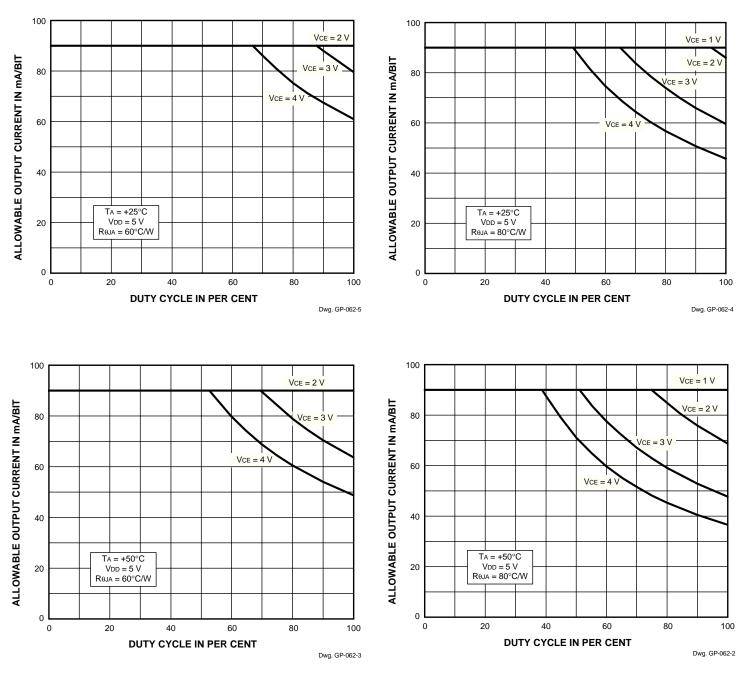
A. Data Active Time Before Clock Pulse	
(Data Set-Up Time), t _{su(D)}	60 ns
B. Data Active Time After Clock Pulse	
(Data Hold Time), t _{h(D)}	20 ns
C. Clock Pulse Width, t _{w(CK)}	50 ns
D. Time Between Clock Activation	
and Latch Enable, t _{su(L)}	100 ns
E. Latch Enable Pulse Width, $t_{w(L)}$	100 ns
F. Output Enable Pulse Width, $t_{w(OE)}$	4.5 µs
NOTE – Timing is representative of a 10 MHz clock.	
Significantly higher speeds are attainable.	
— Max. Clock Transition Time, t _r or t _f	10 µs

Information present at any register is transferred to the respective latch when the LATCH ENABLE is high (serial-toparallel conversion). The latches will continue to accept new data as long as the LATCH ENABLE is held high. Applications where the latches are bypassed (LATCH ENABLE tied high) will require that the OUTPUT ENABLE input be high during serial data entry.

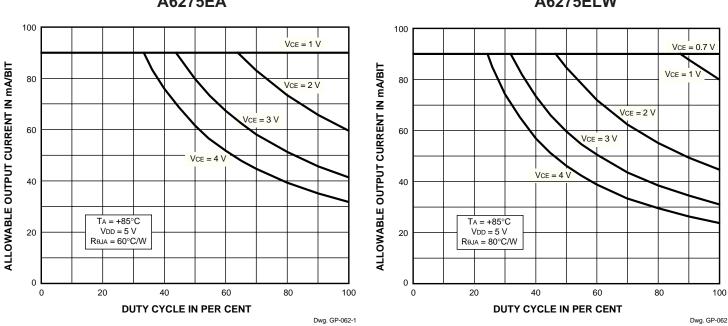
When the OUTPUT ENABLE input is high, the output source drivers are disabled (OFF). The information stored in the latches is not affected by the OUTPUT ENABLE input. With the OUTPUT ENABLE input low, the outputs are controlled by the state of their respective latches.



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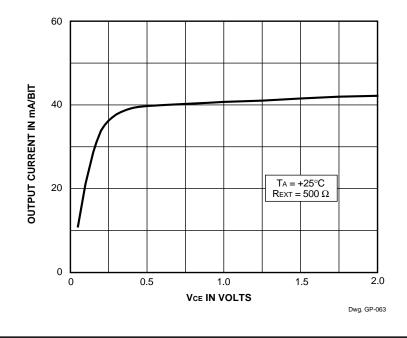


ALLOWABLE OUTPUT CURRENT AS A FUNCTION OF DUTY CYCLE A6275EA A6275ELW



ALLOWABLE OUTPUT CURRENT AS A FUNCTION OF DUTY CYCLE (cont.) A6275EA A6275ELW

TYPICAL CHARACTERISTICS





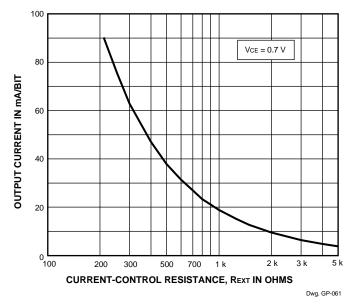
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TERMINAL DESCRIPTION

Terminal No.	Terminal Name	Function
1	GND	Reference terminal for control logic.
2	SERIAL DATA IN	Serial-data input to the shift-register.
3	CLOCK	Clock input terminal for data shift on rising edge.
4	LATCH ENABLE	Data strobe input terminal; serial data is latched with high-level input.
5-12	OUT ₀₋₇	The eight current-sinking output terminals.
13	OUTPUT ENABLE	When (active) low, the output drivers are enabled; when high, all output drivers are turned OFF (blanked).
14	SERIAL DATA OUT	CMOS serial-data output to the following shift-register.
15	R _{EXT}	An external resistor at this terminal establishes the output current for all sink drivers.
16	SUPPLY	(V _{DD}) The logic supply voltage (typically 5 V).

Applications Information

The load current per bit (I_0) is set by the external resistor (R_{EXT}) as shown in the figure below.



Load Supply Voltage (V_{LED}). These devices are designed to operate with driver voltage drops (V_{CE}) of 0.4 V to 0.7 V with LED forward voltages (V_F) of 1.2 V to 4.0 V. If higher voltages are dropped across the driver, package power dissipation will be increased significantly. To minimize package power dissipation, it is recommended to use the lowest possible load supply voltage or to set any series dropping voltage (V_{DROP}) as

 $V_{DROP} = V_{LED} - V_F - V_{CE}$

with $V_{DROP} = I_o \bullet R_{DROP}$ for a single driver, or a Zener diode (V_Z), or a series string of diodes (approximately 0.7 V per diode) for a group of drivers.

For reference, typical LED forward voltages are:

Blue	3.0 - 4.0 V
Green	1.8 - 2.2 V
Yellow	$2.0 - 2.1 \ V$
Amber	1.9 – 2.65 V
Red	1.6 – 2.25 V
Infrared	1.2 - 1.5 V

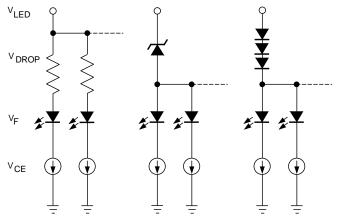


Package Power Dissipation (P_D). The maximum allowable package power dissipation is determined as $P_Dmax = (150 - T_A)/R_{\theta JA}$. The required package power dissipation is

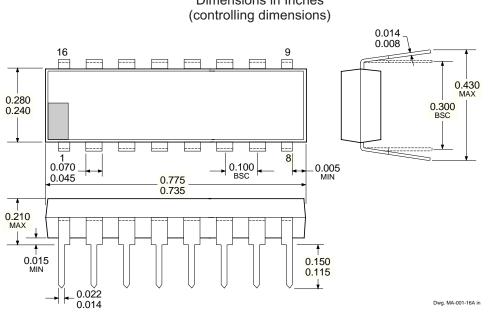
$$P_{D}req = dc(V_{CE} \bullet I_{O} \bullet 8) + (V_{DD} \bullet I_{DD})$$

When the load supply voltage is greater than 3 V to 5 V, considering the package power dissipating limits of these devices, or if $P_D req > P_D max$, an external voltage reducer (V_{DROP}) should be used.

Pattern Layout. This device has a common logic-ground and power-ground terminal. If ground pattern layout contains large common-mode resistance, and the voltage between the system ground and the LATCH ENABLE or CLOCK terminals exceeds 2.5 V (because of switching noise), these devices may not operate correctly.

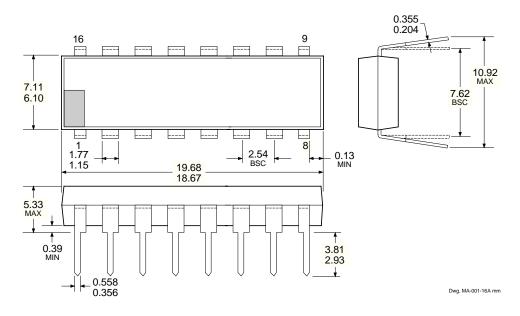


Dwg. EP-064



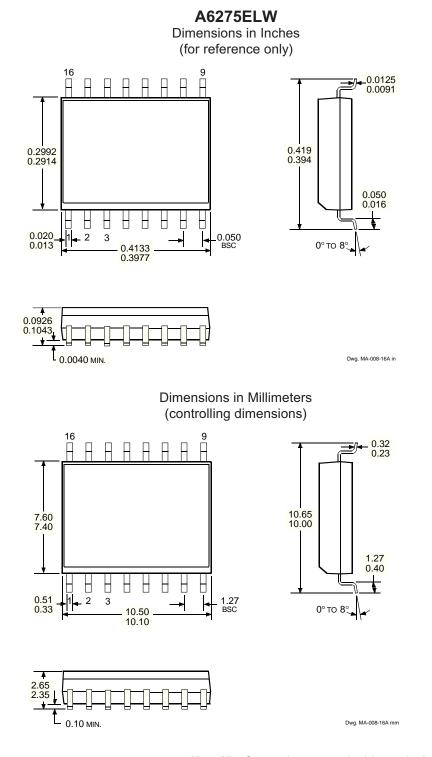
A6275EA Dimensions in Inches controlling dimensions)

Dimensions in Millimeters (for reference only)



NOTES: 1. Exact body and lead configuration at vendor's option within limits shown.

- 2. Lead spacing tolerance is non-cumulative
- 3. Lead thickness is measured at seating plane or below.



NOTES: 1. Exact body and lead configuration at vendor's option within limits shown.

2. Lead spacing tolerance is non-cumulative.



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